

<b>Notice of References Cited</b>	Application/Control No. 10/810,668	Applicant(s)/Patent Under Reexamination ICHIKAWA, KENJI	
	Examiner Thao X. Le	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,646,840	11-2003	Sugerman et al.	361/56
	B	US-6,784,496	08-2004	Brodsky et al.	257/355
	C	US-5,610,790	03-1997	Staab et al.	361/56
	D	US-4,303,958	12-1981	Allgood, Robert N.	361/100
	E	US-6,479,883	11-2002	Chen et al.	257/546
	F	US-5,514,893	05-1996	Miyanaga et al.	257/360
	G	US-6,034,397	03-2000	Voldman, Steven H.	257/335
	H	US-6,239,958	05-2001	Kato et al.	361/56
	I	US-6,809,915	10-2004	Lai et al.	361/111
	J	US-6,885,529	04-2005	Ker et al.	361/56
	K	US-6,744,107	06-2004	Ker et al.	257/401
	L	US-6,608,744	08-2003	Kato, Katsuhiko	361/111
	M	US-6,653,709	11-2003	Wu et al.	257/499

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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